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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/785,153	ISHIKAWA ET AL.	
Examiner	Art Unit	
Seung H. Lee	2876	

SEARCHED			
Class	Subclass	Date	Examiner
235	383	9/30/2005	SHL
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEARC	IOTES CH STRATEGY)
	DATE	EXMR
707/101 (see printouts)	9/30/2005	SHL